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## Second-harmonic generation (SHG) of single dielectric nanoparticles for bio-imaging

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We are studying the optical properties of dielectric nanoparticles in order to use their SHG signal as a label to track the proteins onto which they will be grafted. Why SHG ? The non-resonant process and therefore better photo-thermal stability is expected unlike most fluorescent bio-labels. Most important is the anisotropic character of SHG, advantageously enabling to follow protein rotations.

An inverted confocal microscopy device coupled to an atomic force microscope (AFM) was developed to allow the simultaneous characterization of the topography and SHG properties of single nano-objects.

The first studies were conducted on SiC nanoparticles obtained following crushing and chemical treatment but resulting in polycrystalline aggregates that do not show any significant signal change with polarization. Other BaTiO<sub>3</sub> nanoparticles, synthesized colloiddally, produce single monocrystals. Analyses of their SHG signal emitted as a function of polarization give the theoretical responses expected from the non-linear susceptibility tensor associated to the crystals tetragonal symmetry, in accordance with their orientations as evidenced by AFM. We are now investigating the SHG dependence as a function of the excitation wavelength to understand and quantify the role of Mie resonances.

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### Choix de session parallèle

3.4 SFO et PSV: Photonique et science du vivant

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